

Dual N-channel 30 V, 5.6 mΩ standard level MOSFET

6 November 2013

Product data sheet

### 1. General description

Dual standard level N-channel MOSFET in an LFPAK56D (Dual Power-SO8) package using TrenchMOS technology. This product has been designed and qualified to AEC Q101 standard for use in high performance automotive applications.

## 2. Features and benefits

- Dual MOSFET
- Q101 compliant
- Repetitive avalanche rated
- Suitable for thermally demanding environments due to 175 °C rating
- True standard level gate with  $V_{GS(th)}$  of greater than 1 V at 175  $^\circ\text{C}$

## 3. Applications

- 12 V Automotive systems
- Motors, lamps and solenoid control
- Transmission control
- Ultra high performance power switching

## 4. Quick reference data

Table 1. Qu	ick reference data						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C		-	-	30	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>		-	-	40	А
Static charac	teristics FET1 and FET2						
R <sub>DSon</sub>	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 20 A; T <sub>j</sub> = 25 °C; Fig. 12		-	4.76	5.6	mΩ
Dynamic cha	racteristics FET1 and FE	T2	·				
Q <sub>GD</sub>	gate-drain charge	$I_{D} = 10 \text{ A}; V_{DS} = 24 \text{ V}; V_{GS} = 10 \text{ V};$ $T_{j} = 25 \text{ °C}; \underline{Fig. 14}; \underline{Fig. 15}$		-	9.5	-	nC





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### 5. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source1		
2	G1	gate1		
3	S2	source2		
4	G2	gate2	$\bigcirc$	
5	D2	drain2		 S1 G1 S2 G2
6	D2	drain2		mbk725
7	D1	drain1	1 2 3 4 LFPAK56D (SOT1205)	
8	D1	drain1		

# 6. Ordering information

Table 3. Ordering in	formation					
Type number	Package					
	Name	Description	Version			
BUK7K5R6-30E	LFPAK56D	Plastic single ended surface mounted package (LFPAK56D); 8 leads	SOT1205			

### 7. Marking

Table 4. Marking codes	
Type number	Marking code
BUK7K5R6-30E	75E630

## 8. Limiting values

#### Table 5.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	30	V
V <sub>DGR</sub>	drain-gate voltage	$R_{GS}$ = 20 k $\Omega$ ; $T_j \ge 25 \text{ °C}$ ; $T_j \le 175 \text{ °C}$	-	30	V
V <sub>GS</sub>	gate-source voltage	T <sub>j</sub> ≤ 175 °C; DC	-20	20	V
I <sub>D</sub>	drain current	T <sub>mb</sub> = 25 °C; V <sub>GS</sub> = 10 V; <u>Fig. 1</u>	-	40	А
		T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 10 V; <u>Fig. 1</u>	-	40	А
I <sub>DM</sub>	peak drain current	$T_{mb}$ = 25 °C; pulsed; $t_p \le 10 \ \mu$ s; Fig. 4	-	314	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>	-	64	W
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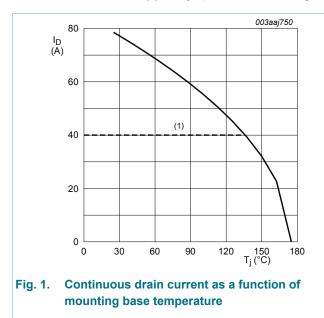
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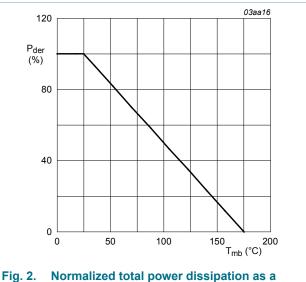
Symbol	Parameter	Conditions		Min	Max	Unit
T <sub>stg</sub>	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
T <sub>sld(M)</sub>	peak soldering temperature			-	260	°C
Source-drain	diode FET1 and FET2		1			-
I <sub>S</sub>	source current	T <sub>mb</sub> = 25 °C		-	40	А
I <sub>SM</sub>	peak source current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^\circ C$		-	314	А
Avalanche Ru	ggedness FET1 and FET2	·				-
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$I_D$ = 40 A; $V_{sup} \le 30$ V; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; <u>Fig. 3</u>	[1][ <u>2]</u>	-	228	mJ

[1] Refer to application note AN10273 for further information

[2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C



 $V_{GS} \ge 10$  V; (1) capped at 40 A due to package.

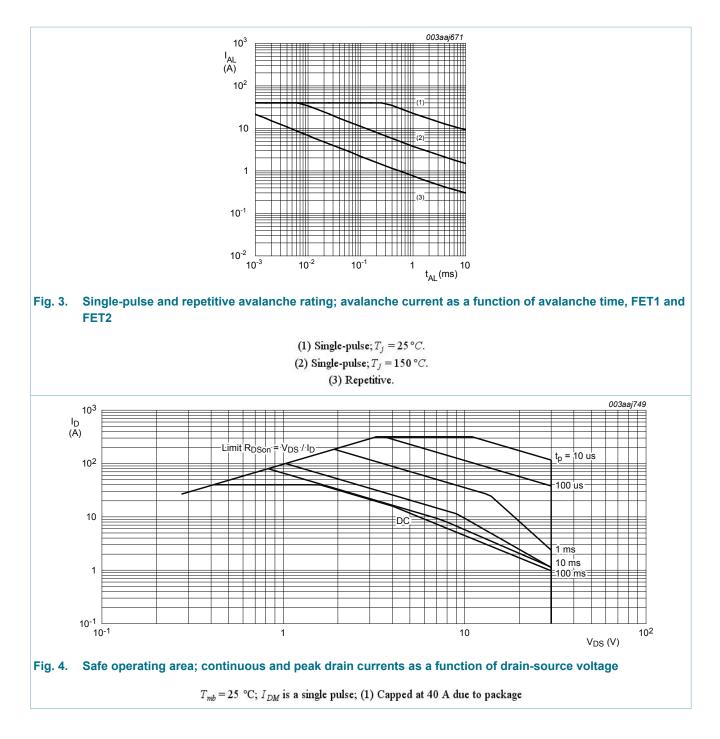


Ig. 2. Normalized total power dissipation as a function of mounting base temperature

$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

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### 9. Thermal characteristics

Table 6. The	rmal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	<u>Fig. 5</u>	-	-	2.36	K/W

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Symbol	Parameter	Conditions			Min	Тур	Max	Unit
₹ <sub>th(j-a)</sub>	thermal resistance from junction to ambient	Minimum footprint; mounted on a printed circuit board		-	95	-	K/W	
10 Z <sub>th(j-mb)</sub> (K/W) 1 δ = 0 1 0.2							003aaj748	
10 <sup>-1</sup>					P		$\delta = \frac{t_p}{T}$	
10-2	single shot					$ \begin{array}{c} \\ \hline \\ $		
10 <sup>-3</sup>	10 <sup>-5</sup>	10 <sup>-4</sup>	10 <sup>-3</sup>	10 <sup>-2</sup>		-1 t <sub>p</sub> (s)	1	

# 10. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	cteristics FET1 and FET2	· · ·	, I			-
V <sub>(BR)DSS</sub>	drain-source	$I_D$ = 250 µA; $V_{GS}$ = 0 V; $T_j$ = -55 °C	27	-	-	V
	breakdown voltage	$I_D$ = 250 µA; $V_{GS}$ = 0 V; $T_j$ = 25 °C	30	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ Fig. 10; Fig. 11	2.4	3	4	V
		I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 175 °C; Fig. 10; Fig. 11	1	-	-	V
		I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = -55 °C; Fig. 10; Fig. 11	-	-	4.5	V
I <sub>DSS</sub>	drain leakage current	$V_{DS}$ = 30 V; $V_{GS}$ = 0 V; $T_j$ = 175 °C	-	-	500	μA
		$V_{DS}$ = 30 V; $V_{GS}$ = 0 V; $T_j$ = 25 °C	-	0.02	1	μA
I <sub>GSS</sub>	gate leakage current	$V_{GS}$ = -20 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C	-	2	100	nA
		V <sub>GS</sub> = 20 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	2	100	nA
Doon	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 20 A; T <sub>j</sub> = 25 °C; <u>Fig. 12</u>	-	4.76	5.6	mΩ
		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 20 A; T <sub>j</sub> = 175 °C; Fig. 12; Fig. 13	-	8.3	10.3	mΩ

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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Dynamic cl	naracteristics FET1 and FE	T2				_
Q <sub>G(tot)</sub>	total gate charge	$I_D$ = 10 A; $V_{DS}$ = 24 V; $V_{GS}$ = 10 V;	-	29.7	-	nC
Q <sub>GS</sub>	gate-source charge	T <sub>j</sub> = 25 °C; <u>Fig. 14; Fig. 15</u>	-	7.6	-	nC
Q <sub>GD</sub>	gate-drain charge	-	-	9.5	-	nC
C <sub>iss</sub>	input capacitance	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz; T <sub>j</sub> = 25 °C; <u>Fig. 16</u>	-	1477	1969	pF
C <sub>oss</sub>	output capacitance		-	380	456	pF
C <sub>rss</sub>	reverse transfer capacitance		-	226	310	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS}$ = 24 V; R <sub>L</sub> = 2.4 Ω; V <sub>GS</sub> = 10 V;	-	9.2	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 5 \Omega; T_j = 25 °C; I_D = 10 A$	-	10	-	ns
t <sub>d(off)</sub>	turn-off delay time	-	-	17.9	-	ns
t <sub>f</sub>	fall time	-	-	12.9	-	ns
Source-dra	in diode FET1 and FET2					
V <sub>SD</sub>	source-drain voltage	$I_{S}$ = 10 A; $V_{GS}$ = 0 V; $T_{j}$ = 25 °C; <u>Fig. 17</u>	-	0.78	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_{S}$ = 10 A; dI <sub>S</sub> /dt = -100 A/µs; V <sub>GS</sub> = 0 V;	-	27.4	-	ns
Q <sub>r</sub>	recovered charge	V <sub>DS</sub> = 15 V; T <sub>j</sub> = 25 °C	-	20.7	-	nC

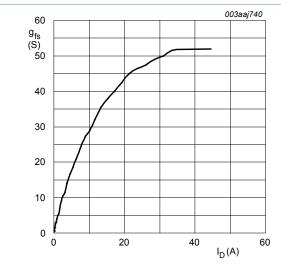
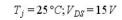


Fig. 6. Forward transconductance as a function of drain current; typical values



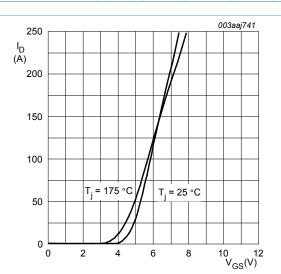
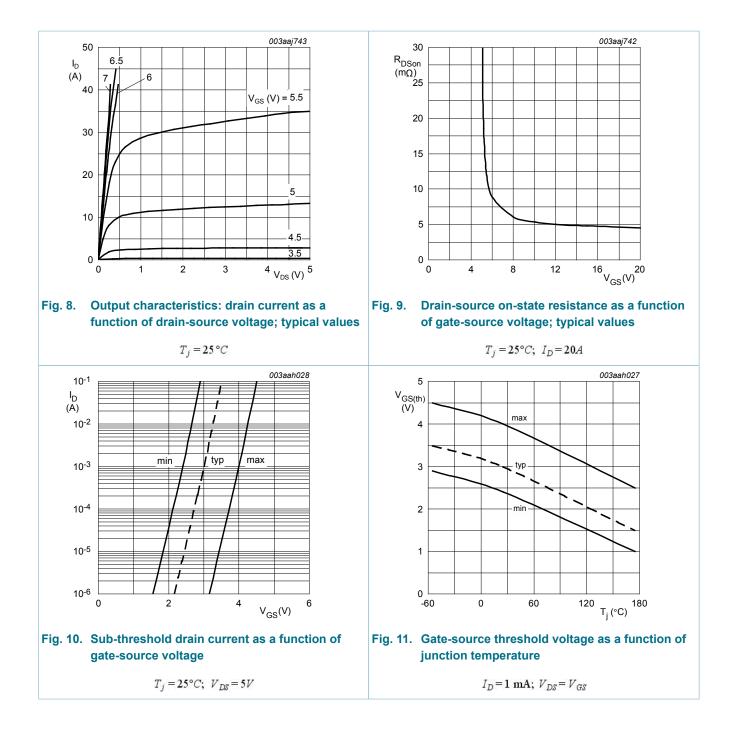


Fig. 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values

 $V_{DS} = 10V$ 

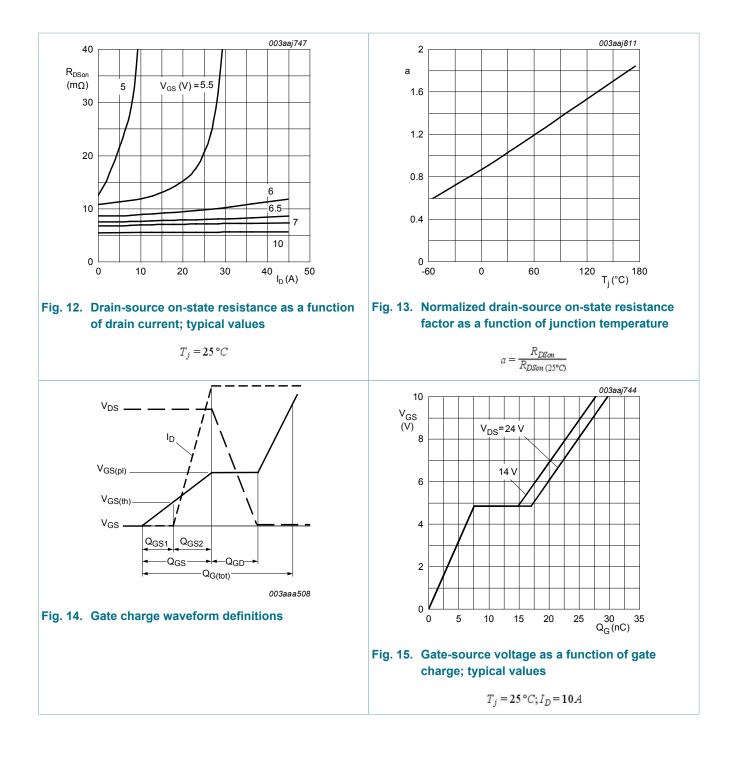
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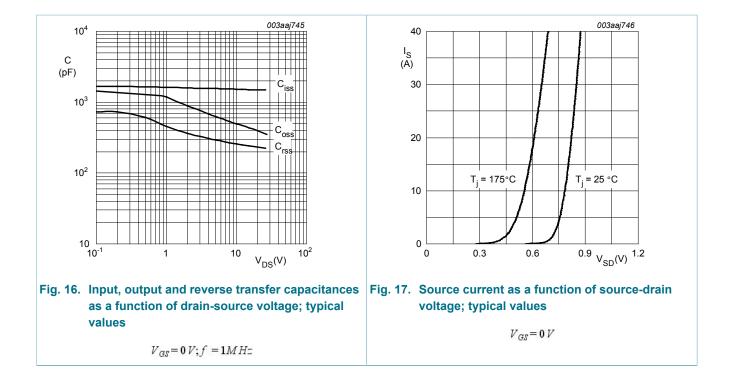
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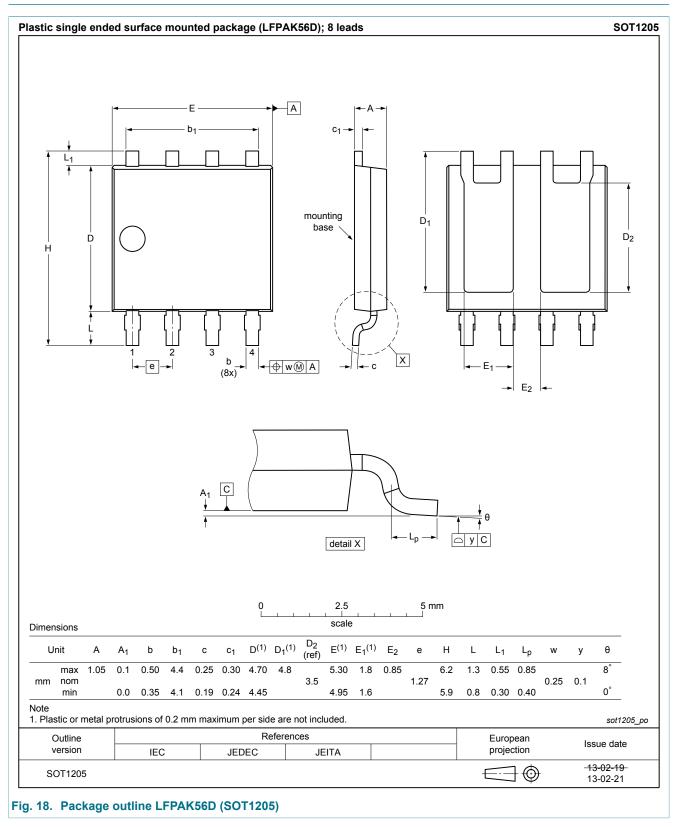
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Dual N-channel 30 V, 5.6 mΩ standard level MOSFET

### 11. Package outline



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Product data sheet

#### Dual N-channel 30 V, 5.6 mΩ standard level MOSFET

### 12. Legal information

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Document status [1][2]	Product status [ <u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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